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WS₂/CsPbBr₃ van der Waals heterostructure planar photodetectors with ultrahigh on/off ratio and piezo-phototronic effect-induced strain-gated characteristics

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ABSTRACT

High-performance, low-power and multifunction-integrated devices are crucial in emerging technologies. Herein, we demonstrate WS₂/CsPbBr₃ van der Waals heterostructure (vdWH) planar photodetectors combining the high mobility of mechanically exfoliated 2D WS₂ nanoflakes with the remarkable optoelectronic properties of 1D single-crystalline CsPbBr₃ nanowires and the strain-gated and strain-sensing characteristics induced by the piezo-phototronic effect. Owing to the effective charge carrier transfer and channel depletion originating from the appropriate energy band alignment, collaborative improvement of the photocurrent and dark current is realized, thus, an ultrahigh on/off ratio of 10^{9.83} is achieved. The highest responsivity and detectivity at V_d = 2 V are 57.2 A W⁻¹ and 1.36 × 10¹⁴ Jones, respectively. Even with a lower V_d of 0.5 V, decent performance is still obtained. Furthermore, the interfacial carrier transfer can be manipulated through the piezo-phototronic effect induced by CsPbBr₃ monocrystal nanowires. Thus, when constructed on a flexible PEN substrate, the WS₂/CsPbBr₃ vdWH planar photodetector presents strain-gated photocurrent and responsivity, modulated by a factor of 11.3 with strain application, and a strain-sensing function is simultaneously realized due to the linear dependence of the photocurrent on strain. This unprecedented device design opens up a new avenue toward not only high-performance and low-power but also multifunction-integrated devices realized by the direct effect of mechanical inputs on charge carriers.

1. Introduction

As a kind of novel material with great potential, two-dimensional (2D) materials are widely studied for electronic and optoelectronic applications owing to their ultrathin thickness, tunable bandgaps and high mobility [1–5]. The interlayer van der Waals (vdW) force and atomically flat interface help 2D materials escape the restrictions arising from lattice matching in heterostructure construction [3,6–8]. Due to the high possibility of combining 2D materials with materials of various dimensions, state-of-the-art optoelectronic heterostructures can be manufactured. Inspired by these efforts, halide perovskites with

remarkable optoelectronic properties [9–11] have been used to assemble heterostructures with 2D materials. Effective and ultrafast charge carrier transfer between perovskites and 2D materials has been widely demonstrated and has been shown to dramatically improve the performance of planar photodetectors [4,12–16]. However, without modulation of gate voltage, the dark currents of these planar 2D-material/perovskite photodetectors are so great that the on/off ratio is low and the standby power is large, which greatly restricts the application of 2D-material/perovskite photodetectors [13,14,17]. Owing to the depletion in WS₂, chemical vapor deposition (CVD)-synthesized monolayer WS₂/CH₃NH₃PbI₃ thin film heterostructure photodetectors

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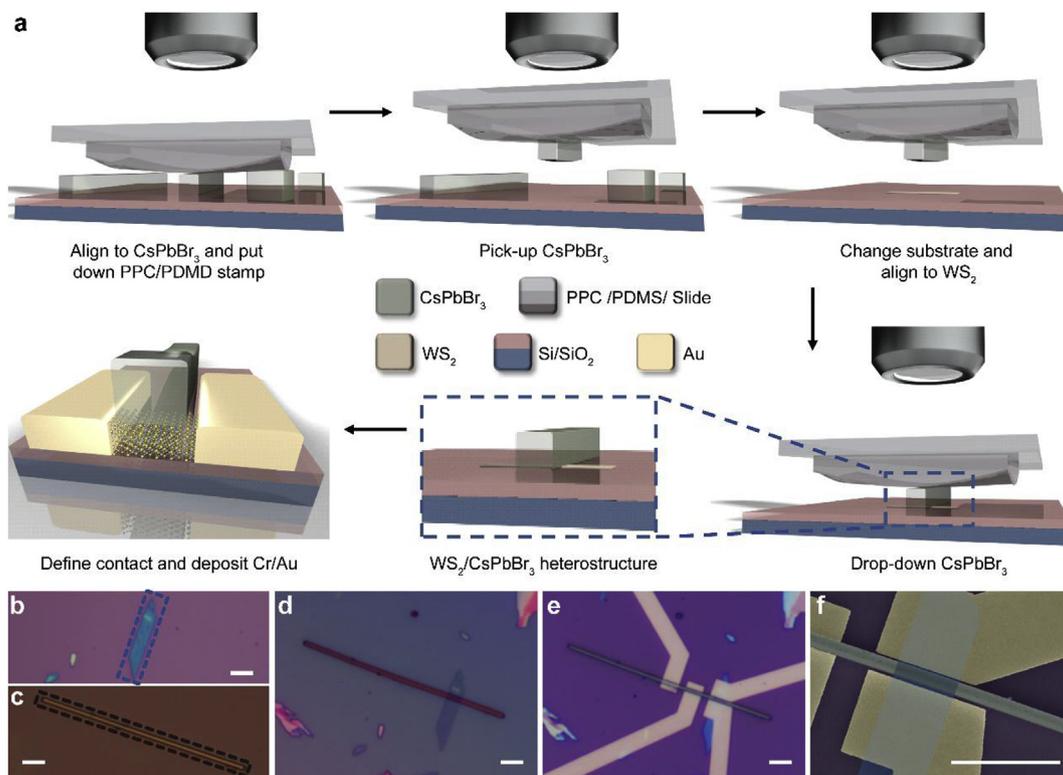


Fig. 1. Assembly processes and device structure of $\text{WS}_2/\text{CsPbBr}_3$ vdWHs. (a) Schematic illustration of device assembly. (b) and (c) Optical micrographs of the chosen 2D WS_2 flake and 1D CsPbBr_3 nanowire for building a vdWH, respectively. (d) Optical micrographs of the assembled $\text{WS}_2/\text{CsPbBr}_3$ vdWH coated by PMMA. (e) and (f) Optical micrographs and false-color SEM image of the $\text{WS}_2/\text{CsPbBr}_3$ vdWH planar photodetector, respectively. Notably, the metal contacts across the CsPbBr_3 nanowire are useless in this work. All the scale bars in (b) ~ (f) are 5 μm .

[15] displayed a good performance with a 10^5 on/off ratio and a 10^{12} Jones detectivity, but the weak mobility limited the performance and the high operating voltage hampered the reduction of energy consumption.

All of the previous reports on 2D-material/perovskite photodetectors utilize 2D material synthesized by CVD or solution process. While mechanical cleavage enables 2D flakes with higher purity and cleanliness to be more easily obtained [1]. The better crystal quality, fewer defects and higher mobility of mechanically exfoliated 2D flakes can endow photodetectors with much higher performance and lower energy dissipation. Moreover, all of these reported heterostructures overwhelmingly employ organic-inorganic hybrid halide perovskites. These perovskites are not stable for many solvents which imposes severe limitations on device construction. Perovskites with disordered orientations, such as polycrystal [12,14,18], quantum dot (QD) [17] and multiple monocrystal [19], were usually used, thus it is a challenge to realize piezotronic or piezo-phototronic effect through the piezoelectric property of halide perovskites. All-inorganic halide perovskite monocrystals, such as CsPbBr_3 , with much better stability, no grain boundaries, a lower trap density and longer carrier diffusion exhibit great potential for constructing high-performance devices. Very recently, the piezoelectric property of CsPbBr_3 [20] has been reported, however the piezotronic or piezo-phototronic effect induced by CsPbBr_3 has not been reported. Piezotronic and piezo-phototronic effects endow traditional devices with not only better performance but also multifunction integration, which is crucial for wearable electronics, human-machine interfaces, the Internet of things, etc [21]. Considering the excellent properties of both mechanically exfoliated 2D flakes and all-inorganic halide perovskite monocrystals, a high-performance, low-power and multifunction-integrated vdWH photodetector can be potentially realized by employing these two kinds of building blocks.

In this study, mechanically exfoliated 2D WS_2 nanoflakes and single-

crystalline 1D CsPbBr_3 nanowires are employed to construct $\text{WS}_2/\text{CsPbBr}_3$ vdWH planar photodetectors for the first time. Attributed to both effective charge carrier transfer and channel depletion, photocurrent enhancement and dark current suppression are simultaneously observed. The assembled devices exhibit an on/off ratio, a responsivity, and a detectivity of up to $10^{9.83}$, 57.2 A W^{-1} , and 1.36×10^{14} Jones, respectively. Compared with previous reports, the high crystal quality of mechanically exfoliated 2D WS_2 gives rise to a significant reduction in V_d . The enhanced photocurrent, ultralow dark current, and significantly reduced V_d endow the $\text{WS}_2/\text{CsPbBr}_3$ vdWH photodetector with low-power and high-performance characteristics. Furthermore, the vdWH photodetector are fabricated on flexible PEN substrate. Through the piezo-phototronic effect, carrier transfer at the interface is modulated. In addition to the performance modulation of the $\text{WS}_2/\text{CsPbBr}_3$ vdWH photodetector, the response to an applied strain is also demonstrated. Thus, high-performance, low-power and multifunction-integrated characteristics are achieved through $\text{WS}_2/\text{CsPbBr}_3$ vdWHs.

2. Experimental section

2.1. CsPbBr_3 nanowire synthesis

The method has been previously reported [11,20,22]. To prepare the precursor solution, 4M CsBr and PbBr_2 are simultaneously dissolved in DMSO at 50 °C, and then, MeCN is added dropwise into the solution until the solution reaches saturation through vigorously stirring for 24 h at 50 °C. After filtration, the solution is dropped onto a hydrophilic Si/SiO₂ substrate using a pipette, and a hydrophobic PDMS template is placed onto the solution. The Si/SiO₂ substrate and PDMS are pressed together. After incubation at 40 °C for 24 h, CsPbBr_3 nanowires and microwires can be grown on the Si/SiO₂ substrates. In this work, only nanowires with diameters varying from 400 nm–1 μm are

used.

2.2. Fabrication process of WS₂/CsPbBr₃ vdWH planar photodetectors

The entire fabrication process of vdWHs is illustrated in Fig. 1a. To build 2D-WS₂/1D-CsPbBr₃ vdWHs on a substrate (Si/SiO₂ or PEN), few-layer WS₂ flakes (Fig. 1b) are first exfoliated onto the target substrate. Then, a CsPbBr₃ nanowire (Fig. 1c) with diameter of 400 nm–1 μm are precisely transferred onto WS₂ through a picking-up and dropping process using the PPC/PDMS stamp. As illustrated in Fig. 1a, a PPC/PDMS stamp adhered on a slide is aligned and contact with the target CsPbBr₃ nanowire. After heating to 60 °C and then cooling to 40 °C, the CsPbBr₃ nanowire is picked-up by the PPC/PDMS stamp. Next, the selected 2D WS₂ flake on the target substrate is placed under a microscope and aligned with the CsPbBr₃ nanowire. Finally, the CsPbBr₃ nanowire is precisely dropped onto the WS₂ flake (Fig. 1d).

Before use as a substrate, PEN is cut into circular pieces 2 cm in diameter, and a 100 nm SiO₂ layer is deposited on it by magnetron sputtering (Kurt J. Lesker PVD75). SiO₂ acts as an adhesion layer because the CsPbBr₃ nanowire cannot be directly attached to the PEN substrate.

To fabricate WS₂/CsPbBr₃ vdWH planar photodetectors, contacts are defined by an electron beam lithography (EBL) process (FEI Helios NanoLab 600i with a Raith SEM-pattern generator), followed by deposition and liftoff of Cr/Au (10/40 nm).

2.3. Characterization and measurement of WS₂/CsPbBr₃ vdWH planar photodetectors

The PL, PL mapping and corresponding decay curve are obtained by steady-state/transient fluorescence spectrometry (FLS980). The crystalline phase of the CsPbBr₃ nanowires is determined by XRD (PANalytical X'Pert3). HR-TEM and SAED of CsPbBr₃ nanowires are conducted (FEI Tecnai G2 F20 S-TWIN TMP) at an accelerating voltage of 80 kV. I-V curves of the photodetectors are measured by a Keithley 4200-SCS. A Stanford DS345 and an SR570 are employed for I-T measurements. The incident power of the 450 nm laser is modulated by an attenuator. When the photodetectors are measured under strain, a manual stage is used as shown in Fig. S5. All electrical measurements are conducted at room temperature.

2.4. Fabrication and measurement of WS₂ photodetectors

To compare photodetector performance of WS₂/CsPbBr₃ vdWH with pristine WS₂, pristine WS₂ photodetectors are fabricated. The fabrication details of WS₂ devices are as same as those of WS₂/CsPbBr₃ devices, except there is no need for constructing vdWHs. And the measurement method is also totally same with that of WS₂/CsPbBr₃ devices.

3. Results and discussion

An optical image of the as-fabricated device is shown in Fig. 1e. Notably, the metal contacts across the CsPbBr₃ nanowire are useless in this work. The SEM image (Fig. 1f) clearly shows that the contacts on the WS₂ channel do not touch the CsPbBr₃ nanowire, confirming that the conducting channel is only WS₂. Compared with the dual channel consisting of both a 2D material and a perovskite that has usually been used in previous reports [12–15,18], the single-channel structure in this work is used for better dark current suppression, as shown below.

To investigate the charge carrier transfer between CsPbBr₃ nanowires and WS₂ nanoflakes, the photoluminescence (PL) of the WS₂/CsPbBr₃ vdWH is measured. Fig. 2a shows that the CsPbBr₃ nanowire possesses a PL peak at approximately 525 nm under a 410 nm excitation laser, which is in agreement with the results in previous reports [23,24]. The PL intensity of the WS₂/CsPbBr₃ vdWH (point A in the inset of Fig. 2a) is smaller than that of pristine CsPbBr₃ (point B). The

corresponding PL mapping is presented in Fig. 2b, which is measured over the entire area shown in the inset of Fig. 2a. The PL mapping is divided in half by a dashed line, and the left part (vdWH area) displays a much lower PL density than the right part (pristine CsPbBr₃ area). To further reveal charge carrier transfer at the interface, time-resolved photoluminescence (TRPL) measurement at points A and B are taken. As shown in Fig. 2c, the TRPL decay curves of the WS₂/CsPbBr₃ vdWH and pristine CsPbBr₃ nanowire are well fitted by a single-exponential function [4]. According to the fitting results, the lifetimes of WS₂/CsPbBr₃ and CsPbBr₃ exciton radiative recombination are 0.84 ns and 1.04 ns, respectively. The PL quenching and the shorter exciton recombination lifetime of the WS₂/CsPbBr₃ vdWH are the results of charge carrier transfer from CsPbBr₃ nanowires to WS₂ nanoflakes [4,15]. The band profile of the WS₂/CsPbBr₃ vdWH is illustrated in Fig. 2d, according to previous reports [1,4,15,16,25]. Because of the appropriate band alignment, under the excitation light, some of the light-induced carriers in CsPbBr₃ are transferred to WS₂. Due to the different barriers for electrons and holes, electrons are transferred more easily, and some excitons in CsPbBr₃ are dissociated. As a result, the radiative recombination is weakened. Meantime, the PL intensity and PL lifetime are reduced. Notably, considering the small thickness and high carrier density of 2D WS₂ flakes compared to CsPbBr₃ nanowires, the entire WS₂ area in good contact with CsPbBr₃ should be depleted, and no flat band part is observed in the vdWH area of WS₂. Thus, the flat band part of WS₂ shown in Fig. 2d is included here only for convenience in depicting the excited and transferred charge carriers within WS₂.

Raman spectra are important for revealing the structure of 2D materials. As depicted in Fig. 2e, under a 633 nm excitation laser, the main WS₂ Raman peaks of 2LA(M) at 351.27 cm⁻¹ and A_{1g}(Γ) at 419.73 cm⁻¹ are obtained in the pristine WS₂ area [26] (point C in the inset of Fig. 2a), while no Raman peak is observed for pristine CsPbBr₃ (point B) except for the peak at 520 cm⁻¹ from the Si/SiO₂ substrate. For the WS₂/CsPbBr₃ vdWH (point A), the Raman spectrum is still dominated by WS₂ Raman peaks. As shown in Fig. 2f, which is a magnification of the framed area in Fig. 2e, the 2LA(M) peak at 351.27 cm⁻¹ for pristine WS₂ is shifted slightly to 349.55 cm⁻¹ for the WS₂/CsPbBr₃ vdWH, and the redshift of the 2LA(M) peak is consistent with a previous report [15]. This result indicates that the WS₂ structure is not subjected to damage during the heterostructure fabrication process.

In addition to the highly efficient charge carrier transfer, another merit of the WS₂/CsPbBr₃ vdWHs is the depletion of the WS₂ channel. For the pristine WS₂ channel without CsPbBr₃, as depicted in Fig. 2g and f, no suppression of the dark current occurs. For the WS₂/CsPbBr₃ vdWH planar photodetector illustrated in Fig. 2i and j, the depletion within the WS₂ channel will significantly suppress the dark current.

Fig. 3a displays I-V curves of the pristine WS₂ and WS₂/CsPbBr₃ vdWH photodetectors. The channel length and width of the measured WS₂ photodetector are ~1 μm and ~4.5 μm, respectively, while the channel length and width of the measured WS₂/CsPbBr₃ photodetector are ~1.2 μm and ~4.1 μm, respectively. The effective incident light intensity is defined as $P_{eff} = P_{in} \times (A_{device}/A_{laser})$, where P_{in} is the incident light intensity and A_{device} is the active area, equal to the product of the channel length and width. Under the same incident 450 nm laser, the P_{eff} values of the WS₂ and WS₂/CsPbBr₃ devices are 1.59 and 1.72 μW, respectively, which are very similar to each other. Fig. 3a shows that the dark current and photocurrent of the WS₂/CsPbBr₃ photodetector are suppressed and enhanced, respectively; thus, the on/off ratio is remarkably increased. Detailed statistics of the photocurrent density (J_{ph}) and on/off ratio are exhibited in Fig. 3b and c, respectively. Data from six WS₂ photodetectors and nine WS₂/CsPbBr₃ photodetectors are collected to obtain the statistics. J_{ph} is calculated by $J_{ph} = I_{ph}/W_{channel}$ where I_{ph} is the photocurrent ($I_{ph} = I_{light} - I_{dark}$) and $W_{channel}$ is the WS₂ channel width. A mean J_{ph} of 2.20 μA μm⁻¹ is obtained for the WS₂ photodetectors, and that obtained for the WS₂/

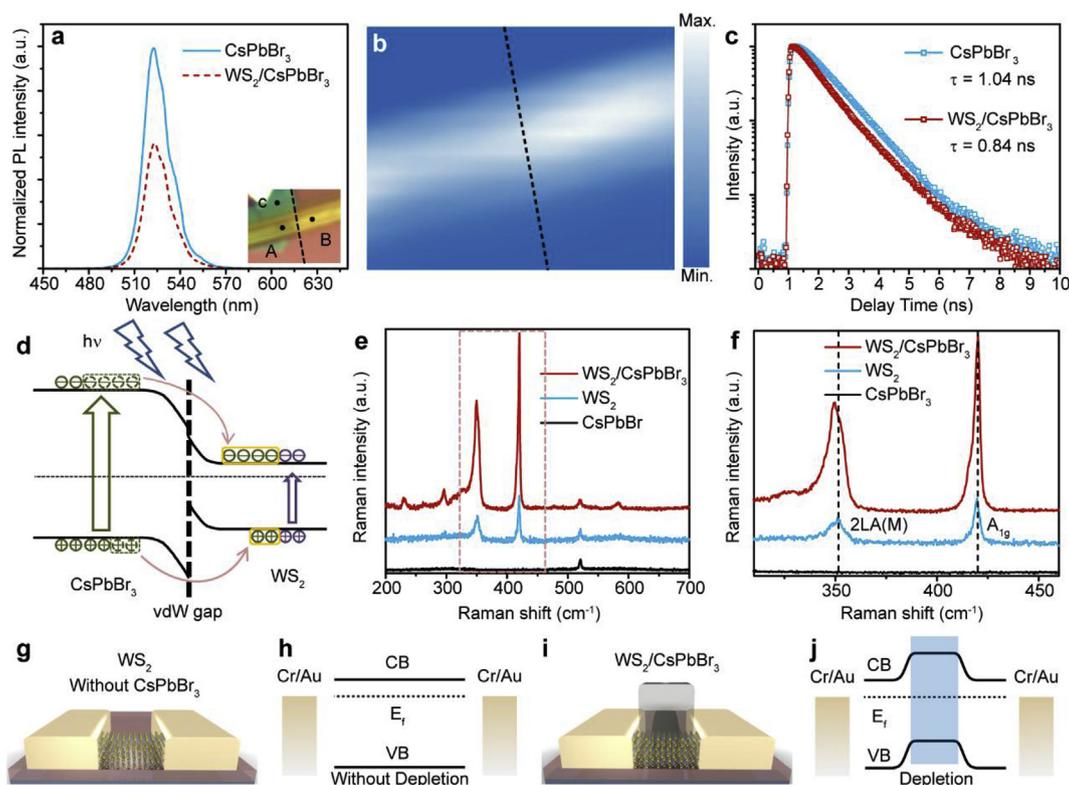


Fig. 2. Spectral patterns and band structure of a WS₂ channel section. (a) PL spectra of CsPbBr₃ and the WS₂/CsPbBr₃ vdWH, in which the inset shows the measurement points. Point A, B and C response WS₂/CsPbBr₃ vdWH, pristine CsPbBr₃ and pristine WS₂, respectively. (b) PL mapping of the WS₂/CsPbBr₃ vdWH. The dashed line corresponds to that shown in the inset of (a). (c) TRPL spectra of CsPbBr₃ and the WS₂/CsPbBr₃ vdWH. (d) Band structure of WS₂/CsPbBr₃ vdWHs, illustrating that charge carriers transfer from CsPbBr₃ to WS₂. (e) Raman spectra of WS₂/CsPbBr₃, WS₂, and CsPbBr₃ acquired under a 633 nm laser. (f) Magnification of the area indicated by the rectangular frame in (e). (g) and (h) Schematic illustration and band structure of the WS₂ channel section for pristine WS₂ photodetectors, respectively. (i) and (j) Schematic illustration and band structure of the WS₂ channel section for WS₂/CsPbBr₃ vdWH photodetectors, respectively. Notably, the entire WS₂ area in good contact with CsPbBr₃ should be depleted; thus, the flat band part of WS₂ in Fig. 2d is included here only for convenience in depicting the excited and transferred charge carriers within WS₂.

CsPbBr₃ photodetectors is nearly double this value at $4.37 \mu\text{A} \mu\text{m}^{-1}$. The experimentally obtained J_{ph} values are clearly shown by the points with dashed lines in Fig. 3d, and the distribution of J_{ph} values is also presented. The overall J_{ph} of the WS₂/CsPbBr₃ photodetectors is almost twice that of the WS₂ photodetectors, and 66.7% of the WS₂/CsPbBr₃ photodetectors exceed the best J_{ph} of the WS₂ photodetectors. The noticeable increase in J_{ph} can be attributed to the efficient photon-generated carrier transfer [2,12,17] from CsPbBr₃ to the WS₂ channel. Moreover, both the pristine WS₂ and WS₂/CsPbBr₃ vdWH photodetector devices present much higher J_{ph} and much lower operating voltage than those in a previous report [15] that utilize CVD-WS₂ as channel. This result indicates that the high crystal quality of mechanically exfoliated WS₂ is well preserved in our devices. With increasing photocurrent, the dark current is suppressed through depletion of the channel (Fig. 2j). Owing to the simultaneous increase in the photocurrent and decrease in the dark current, the on/off ratios for WS₂/CsPbBr₃ photodetectors are dramatically increased, as shown in Fig. 3c. The mean on/off ratio of the WS₂ photodetectors is $10^{4.29}$, while that of the WS₂/CsPbBr₃ photodetector is as high as $10^{8.52}$. That is, an increase of more than 4 orders of magnitude is achieved. The experimentally obtained on/off ratios are presented in Fig. 3e, further showing that all WS₂/CsPbBr₃ photodetectors achieve higher on/off ratios than WS₂. These results preliminarily reveal the high performance of WS₂/CsPbBr₃ vdWH planar photodetectors.

To explicitly reveal the performance of the WS₂/CsPbBr₃ photodetector, I-V curves obtained under different incident light intensities are presented in Fig. 3f. Fig. 3g shows the corresponding light intensity dependence of I_{ph} at $V_d = 2 \text{ V}$. A responsivity ($R = \text{defined as } I_{ph}/P_{eff}$) of

as high as 57.2 A W^{-1} is observed for the WS₂/CsPbBr₃ photodetector in Fig. 3h, while the highest responsivity of the WS₂ device is 16.7 A W^{-1} (Fig. S2a). The responsivity presents a decrease with increasing light power. The EQE is calculated by $EQE = hcI_{ph}/e\lambda P_{eff}$, in which h is the Planck constant, c is the speed of light, e is the absolute value of electronic charge, and λ is the wavelength of the incident laser [27]. The highest EQEs of the WS₂/CsPbBr₃ (Fig. 3h) and WS₂ (Fig. S2c) photodetectors are 157.9 and 46.0, respectively. Fig. 3i and Fig. S2d illustrate the maximum on/off ratio and detectivity of the WS₂/CsPbBr₃ and WS₂ photodetectors, respectively. The maximum on/off ratio of WS₂/CsPbBr₃ ($10^{9.83}$) is significantly larger than that of the WS₂ device ($10^{4.76}$). The detectivity (D^*) is defined as $D^* = R/(A_{device}/2eI_{dark})^{1/2}$, and D^* values of up to 1.36×10^{14} and 1.73×10^{11} Jones, respectively, are obtained for the WS₂/CsPbBr₃ and WS₂ photodetectors. All the results demonstrate that the performance of the WS₂/CsPbBr₃ vdWH photodetector is remarkably improved by interfacial carrier transfer and depletion of the conducting channel. To present the device performance at a lower operating voltage, the corresponding I_{ph} , R and D^* of the WS₂/CsPbBr₃ photodetector at $V_d = 0.5 \text{ V}$ are shown in Fig. S3. According to Fig. S3, the maximum R and D^* can reach 7.3 A W^{-1} and 2.4×10^{13} Jones, with $P_{eff} = 41.56 \text{ nW}$. Thus, the WS₂/CsPbBr₃ photodetector can still show good performance at a lower operating voltage of 0.5 V , which clearly reduces the device energy consumption. The time-dependent photocurrent response of the WS₂/CsPbBr₃ photodetector is revealed in Fig. 3j. Rise and decay times of $\sim 2 \text{ ms}$ are obtained, which are similar to those in previous reports.

In previous reports, 2D material/perovskite vdWHs usually consisted of perovskites with disordered orientations. While monocrystal

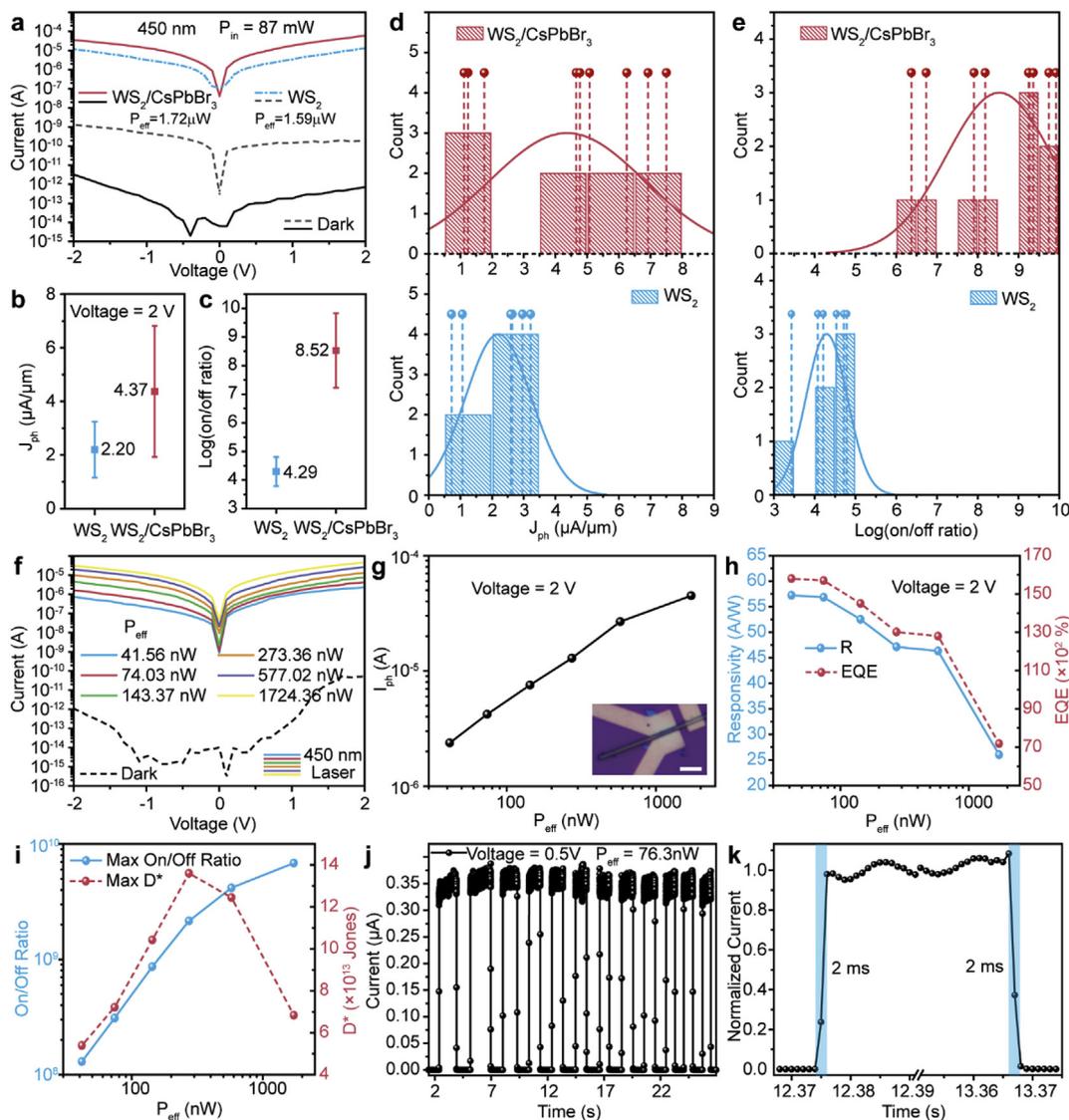


Fig. 3. Performance of $\text{WS}_2/\text{CsPbBr}_3$ vdWHs compared with pristine WS_2 and the detailed performance of the $\text{WS}_2/\text{CsPbBr}_3$ vdWH planar photodetector. (a) I-V curves of the pristine WS_2 (dashed line) and $\text{WS}_2/\text{CsPbBr}_3$ vdWH (solid line) photodetectors, respectively. (b) and (c) Statistics of J_{ph} and the maximum on/off ratio, Data are collected from six pristine WS_2 photodetectors and nine $\text{WS}_2/\text{CsPbBr}_3$ vdWH photodetectors. (d) Relevant distribution of the J_{ph} of the pristine WS_2 and $\text{WS}_2/\text{CsPbBr}_3$ vdWH photodetectors. The points with dashed lines represent experimentally obtained J_{ph} values of the devices. (e) Distribution of the maximum on/off ratio of the pristine WS_2 and $\text{WS}_2/\text{CsPbBr}_3$ vdWH photodetectors. The points with dashed lines represent experimentally obtained on/off ratio values of the devices. (f) I-V curves of the $\text{WS}_2/\text{CsPbBr}_3$ vdWH photodetector under different light intensities. (g) Corresponding light intensity dependence of I_{ph} at $V_d = 2$ V. (h) Corresponding responsivity and EQE of the measured photodetector under different light intensities. (i) Maximum on/off ratio and detectivity of the measured photodetectors. (j) Time-dependent photocurrent response of a device at $V_d = 0.5$ V under $P_{eff} = 76.3$ nW. (k) Partial enlargement of (j), presenting rise and decay times of both ~ 2 ms.

perovskite possesses uniform direction of piezo-polarization even without external applied electric field, this feature enables strain-gated and strain-sensing characteristics induced by the piezo-phototronic effect. To realize these unique characteristics, $\text{WS}_2/\text{CsPbBr}_3$ vdWH planar photodetectors are assembled on flexible PEN substrates using the same process applied on Si/SiO_2 substrates. Fig. S5 demonstrates the testing method for applying strain as well as optical images of a PEN substrate under tensile and compressive strains. Fig. 4a presents I-V curves of the flexible $\text{WS}_2/\text{CsPbBr}_3$ vdWH planar photodetector under different strains, and Fig. 4b exhibits corresponding optical micrographs of the $\text{WS}_2/\text{CsPbBr}_3$ vdWH before metal deposition, in which the diameter and length of the CsPbBr_3 nanowire are ~ 600 nm and ~ 115 μm , respectively. As shown in Fig. 4a, the photocurrent increases with tensile strain and decreases with compressive strain, while the effect of strain on the dark current is negligible, as presented in Fig. S6. By contrast, nearly identical I-V curves are observed for the pristine WS_2

photodetector on the PEN substrate (Fig. S7). The corresponding strain-dependent I_{ph} and responsivity are shown in Fig. 4b, and the corresponding I_{ph}/I_{ph0} and R/R_0 are presented in Fig. 4c, in which I_{ph0} and R_0 are the photocurrent and responsivity without strain, respectively. When the compressive strain increases from 0% to -0.108% , R is reduced from 0.27 to 0.06 A W^{-1} , whereas when the tensile strain increases from 0% to $+0.108\%$, R is increased to 0.68 A W^{-1} . A value of 11.3 for I_{ph}/I_{ph0} is achieved during the strain change from -0.108% to $+0.108\%$. Because the strain dependence of I_{ph} is approximately linear, on-chip sensing of applied strain is enabled.

The suppression of the photocurrent and responsivity for both the $\text{WS}_2/\text{CsPbBr}_3$ (Fig. 4a) and WS_2 (Fig. S7) devices on PEN are attributed to two factors, which are the transparency and inferiority of the surface SiO_2 layer of the PEN substrates. In contrast to Si/SiO_2 , transparent PEN almost does not reflect incident light, which leads to limited light absorption for devices on PEN; thus, a reduced photocurrent is observed.

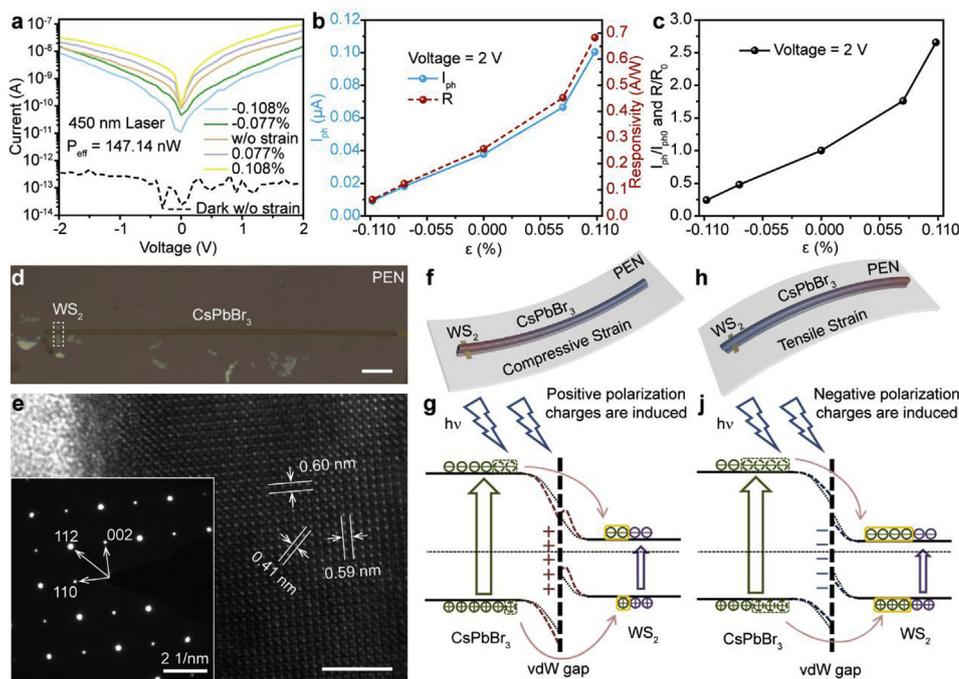


Fig. 4. Strain-gated characteristics of the $\text{WS}_2/\text{CsPbBr}_3$ vdWH planar photodetector originating from the piezo-phototronic effect. (a) I-V curves of the $\text{WS}_2/\text{CsPbBr}_3$ photodetector under different strains. (b) Corresponding strain dependence of I_{ph} and the responsivity. (c) Strain dependence of I_{ph}/I_{ph0} and R/R_0 . (d) Optical micrographs of $\text{WS}_2/\text{CsPbBr}_3$ vdWHs measured in (a) before EBL and the metal deposition process. The scale bar is 10 μm . (e) HR-TEM image of the CsPbBr_3 nanowire; the inset presents the corresponding SAED pattern, which is indexed to an orthorhombic phase with a $\langle 110 \rangle$ zone axis. The scale bar is 5 nm. (f) Schematic illustration of the $\text{WS}_2/\text{CsPbBr}_3$ photodetector under compressive strain, in which the red part indicates a positive piezopotential, while the blue part indicates a negative piezopotential. In this case, a positive piezoelectric polarization is induced. (g) Band structure of the $\text{WS}_2/\text{CsPbBr}_3$ photodetector in (f). (h) Schematic illustration of the device under tensile strain, which induces a negative piezoelectric polarization in this case. (i) Band structure of the device in (h). Notably, the WS_2 channel is depleted; thus, the flat band part of WS_2 is included here only for convenience in depicting the excited and transferred charge carriers within WS_2 , similar to in Fig. 2d.

More importantly, the SiO_2 layer is deposited on the PEN substrate by magnetron sputtering before transferring $\text{WS}_2/\text{CsPbBr}_3$ or WS_2 onto it. SiO_2 acts as an adhesion layer because the CsPbBr_3 nanowire cannot be directly attached to the PEN substrate. Since 2D materials are strongly sensitive to charged impurities in and the surface roughness of the substrates [28,29], the carrier mobility of WS_2 is dramatically limited by the SiO_2 layer deposited using magnetron sputtering. Novel strategies have been proposed to protect the high mobility of 2D channels from the negative impacts of a substrate. For instance, a suspended device structure [30] is appealing for completely avoiding influences from a substrate, and h-BN with an atomically smooth surface is an ideal substrate candidate for devices with high mobility [29]. However, severe limitations are imposed on device fabrication using these strategies [6,29]. Therefore, further efforts to improve the surface nature of flexible substrates are needed.

To illuminate the mechanism of the strain-gated characteristic induced by the piezo-phototronic effect, the crystal structure of the CsPbBr_3 nanowire is first characterized. The XRD pattern is exhibited in Fig. S9a, indicating an orthorhombic phase similar to that previously reported [23,24]. Fig. 4e and the inset present a high-resolution transmission electron microscopy (HR-TEM) image and a selected area electron diffraction (SAED) pattern of a CsPbBr_3 nanowire section (Fig. S9d). According to the XRD pattern and Crystallographic Information File (cif) document of orthorhombic CsPbBr_3 , the SAED spots are indexed to (002), (112) and (110), which correspond to lattice fringes of 0.6 nm, 0.41 nm and 0.59 nm, respectively, and the zone axis is $\langle 110 \rangle$. These results indicate the single-crystalline nature and that the crystalline growth direction is along $\langle 110 \rangle$. Because of the low-symmetry structure of orthorhombic CsPbBr_3 , it is proposed that when the lattice is distorted by an applied strain, piezo-polarization charges and corresponding piezopotential will be generated in CsPbBr_3 nanowires [20].

According to Fig. S6, in which the dark current only changes by less than 1 pA at $V_d = 2$ V with strain varying from -0.153% to $+0.153\%$, the piezopotential, acting as a gate voltage, presents a relatively weak electric field modulation effect on the WS_2 channel; thus, only the piezo-phototronic effect is mainly considered. The piezo-phototronic effect is defined as the modulation of the generation, separation, diffusion and recombination of photon-induced carriers by the

piezopotential [31–33]. As shown in Fig. 4f and g, when positive polarization charges are induced at the $\text{WS}_2/\text{CsPbBr}_3$ interface by strain (compressive in this case), considering the change in the work function of CsPbBr_3 and the constant thermal equilibrium state between WS_2 and CsPbBr_3 , both energy bands of these two materials bend further, and only the energy band of WS_2 at the interface very slightly reversely bends due to the weak electric field modulation effect (red dashed line in Fig. 4g). The barrier for interfacial carrier transfer is strengthened, and the channel depletion overall remains. Therefore, although incident light is strongly absorbed by the perovskite, interfacial carrier transfer is difficult, and finally, the photocurrent is highly reduced. In contrast, when negative polarization charges are induced at the WS_2 interface due to strain (tensile in this case), as illustrated in Fig. 4h, both energy bands of these two materials reversely bend (blue dashed line in Fig. 4i) compared with the energy bands without strain. Therefore, the barrier for interfacial carrier transfer is weakened, and thus, the interfacial carrier transfer and photocurrent are improved. In short, the strain-gated performance and strain-sensing function of the $\text{WS}_2/\text{CsPbBr}_3$ vdWH planar photodetector are induced by the piezo-phototronic effect.

4. Conclusion

In conclusion, 2D- WS_2 /1D- CsPbBr_3 vdWH planar photodetectors are assembled and characterized for the first time. Efficient charge carrier transfer from CsPbBr_3 to WS_2 is verified by the reduction in the PL intensity compared to pristine CsPbBr_3 . Light-induced carrier transfer to WS_2 and depletion of the WS_2 channel enable simultaneous increase of the photocurrent and decrease of the dark current, as demonstrated by the I-V curves and ultrahigh on/off ratio of the $\text{WS}_2/\text{CsPbBr}_3$ vdWH planar photodetector. In addition to an on/off ratio of up to $10^{9.83}$, the highest R , D^* and EQE are 57.2 A W^{-1} , 1.36×10^{14} Jones and 157, respectively. The I-T curves show fast rise and decay times of ~ 2 ms. Moreover, owing to the high crystal quality of mechanically exfoliated 2D WS_2 , the $\text{WS}_2/\text{CsPbBr}_3$ photodetector can still present incredible performance even at a V_d of 0.5 V. The piezoelectric property of monocrystalline CsPbBr_3 nanowires endow $\text{WS}_2/\text{CsPbBr}_3$ photodetectors with strain-gated characteristics and a strain-sensing function induced by the piezo-phototronic effect. Modulation of I_{ph} and

R by a factor of 11.3 is achieved, and the linear strain dependence of I_{ph} enables on-chip strain sensing for $WS_2/CsPbBr_3$ devices. This work illustrates a new device design for photodetectors with high performance, low energy consumption and multifunction integration toward emerging technologies.

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Appendix A. Supplementary data

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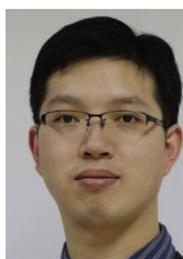
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